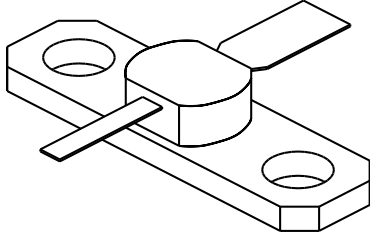


<p><b>GENERAL DESCRIPTION</b> The 2010 is a COMMON BASE transistor capable of providing 10 Watts Class C, RF output power at 2000 MHz. Gold metalization and diffused ballasting are used to provide high reliability and supreme ruggedness. The transistor uses a fully hermetic High Temperature Solder Sealed package.</p>	<p><b>CASE OUTLINE</b> <b>55BT-1, Style</b></p> 
<p><b>ABSOLUTE MAXIMUM RATINGS</b></p> <p>Maximum Power Dissipation @ 25°C <span style="float: right;">30 Watts</span></p> <p><b>Maximum Voltage and Current</b></p> <p>BVces Collector to Emitter Voltage <span style="float: right;">50 Volts</span>          BVebo Emitter to Base Voltage <span style="float: right;">3.5 Volts</span>          Ic Collector Current <span style="float: right;">2.0 A</span></p> <p><b>Maximum Temperatures</b></p> <p>Storage Temperature <span style="float: right;">- 65 to + 200°C</span>          Operating Junction Temperature <span style="float: right;">+ 200°C</span></p>	

**ELECTRICAL CHARACTERISTICS @ 25 °C**

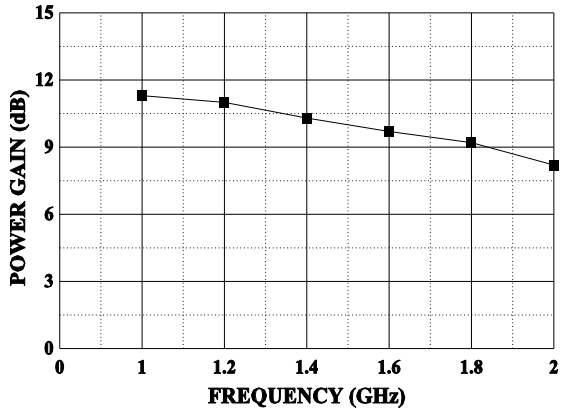
SYMBOL	CHARACTERISTICS	TEST CONDITIONS	MIN	TYP	MAX	UNITS
<b>Pout</b>	Power Out	F = 2 GHz	10			Watt
<b>Pin</b>	Power Input	Vcb = 28 Volts			2	Watt
<b>Pg</b>	Power Gain	Po = 10 Watts	7.0	8.0		dB
$\eta_c$	Collector Efficiency	As Above		40		%
<b>VSWR<sub>1</sub></b>	Load Mismatch Tolerance	F = 2 GHz, Po = 10 W			20:1	

<b>BVces</b>	Collector to Emitter Breakdown	Ic = 20 mA	50			Volts
<b>BVcbo</b>	Collector to Base Breakdown	Ic = 4 mA	45			Volts
<b>BVebo</b>	Emitter to Base Breakdown	Ie = 4 mA	3.5			Volts
<b>Icbo</b>	Collector to Base Current	Vcb = 28 Volts			4.0	mA
<b>h<sub>FE</sub></b>	Current Gain	Vce = 5 V, Ic = 400 mA	20			
<b>Cob</b>	Output Capacitance	F = 1 MHz, Vcb = 28 V				pF
$\theta_{jc}$	Thermal Resistance				6.0	°C/W

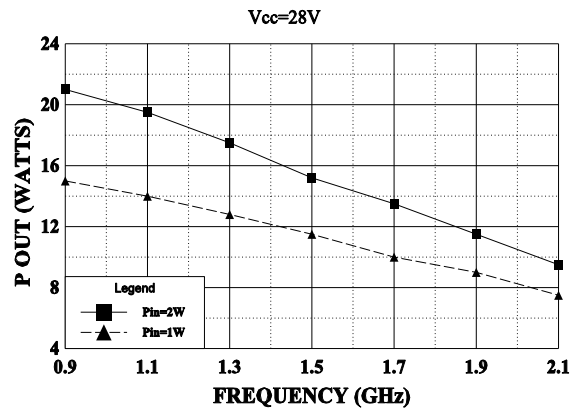
Issue August 1996

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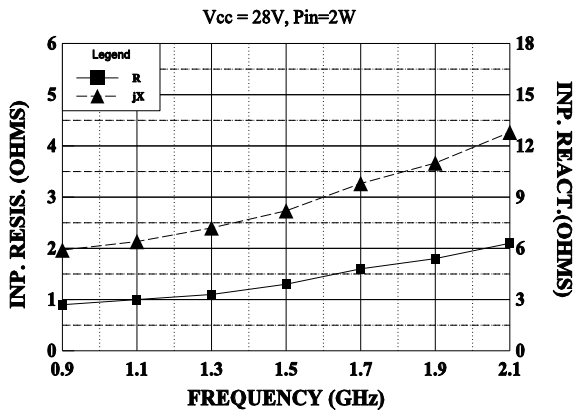
**POWER GAIN VS FREQUENCY**



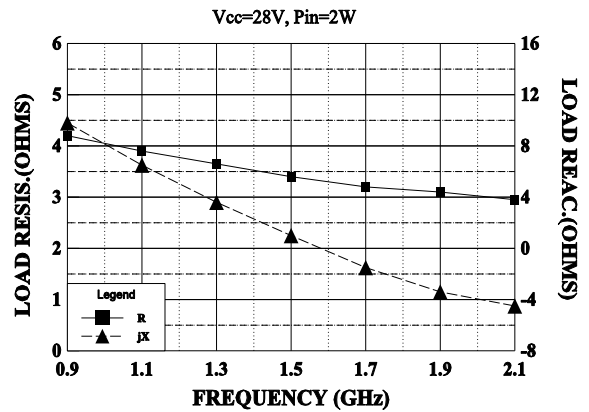
**POWER OUTPUT VS FREQUENCY**



**SERIES INPUT IMPEDANCE VS FREQUENCY**

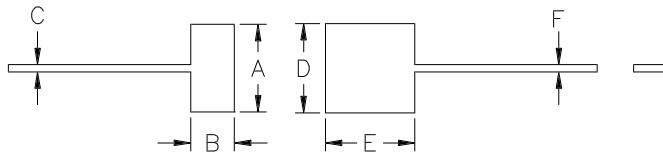


**SERIES LOAD IMPEDANCE VS FREQUENCY**



REVISIONS

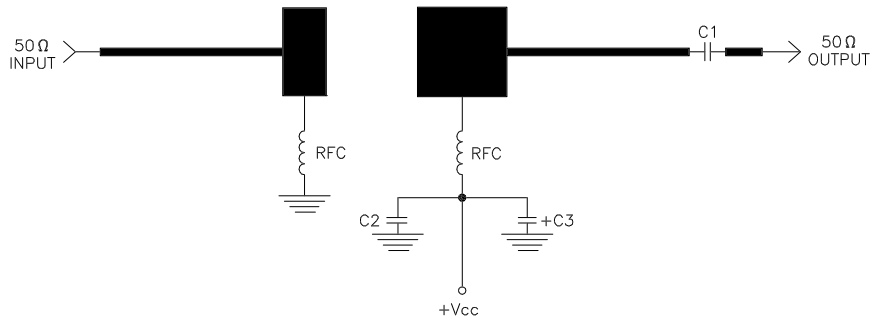
ZONE	REV	DESCRIPTION	DATE	APPROVED
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DIM	INCHES
A	.480
B	.240
C	.040
D	.490
E	.490
F	.040

2000 MHz TEST AMPLIFIER

Vcc = 28V



NOTE 1. Under the normal operating conditions as specified, junction temperature to be 200° maximum as measured by I.R. scan of the chip. Thermal Resistance = 6° C/W Junction to Case.

— = Microstrip on 0.020" Teflon Fiberglass, Er=2.55  
 C1,C2 = 47 pf chip cap  
 C3 = 10µfd @ 35 VOLTS



CAGE	DWG NO.	REV
OPJR2	2010	A
SCALE	1/1	SHEET